

AEM Testing Innovation

Assuring Cabling Infrastructure Readiness: Advanced Cable Testing for Standard and Single-Pair Ethernet

Steve Cowles, RCDD/NTS

CINI4.0 Conference Day 16/06/2022, Gent

cornet

We Are Testing Innovation

AEM's mission is to provide the most comprehensive semiconductor and electronics test solutions based on the best-in-class technologies, processes and customer support.



Test Cells Solutions





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System Level Test Solutions >

Wafer Level Test Solutions >

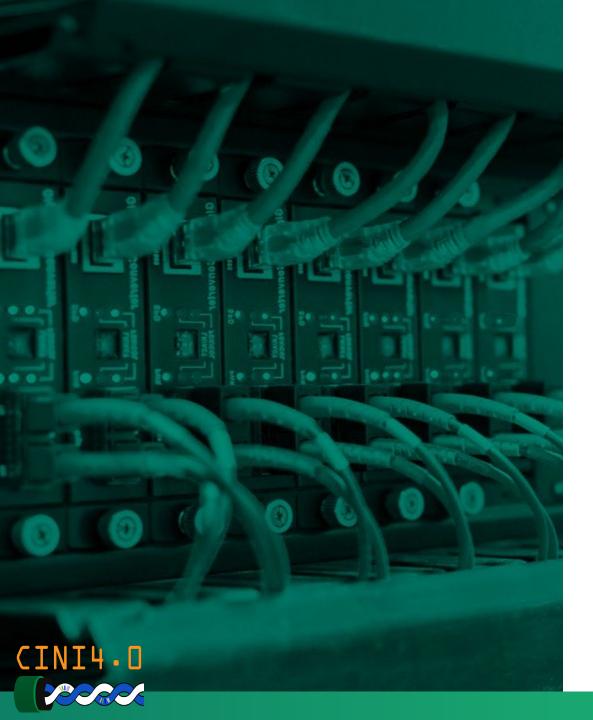
Instrumentation



ATE Solutions >



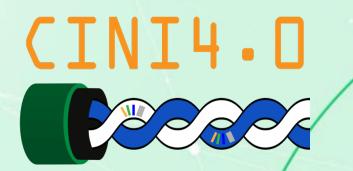
Test & Measurement Solutions >



Presentation Agenda

- Cable Certification Testing basics
 - Required, optional and informational test parameters
 - Common causes of test failures
 - Additional testing considerations
- Single Pair Ethernet
 - Environments
 - Standards
 - Topology
 - Power over Single Pair (PoDL and SPoE)
 - SPE testing

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Cabling Certification Test Parameters



Pass/Fail Criteria

- Length
- Delay
- Delay Skew
- Loop Resistance
- Insertion Loss
- Return Loss
- NEXT
- PSNEXT
- ACRF
- PSACRF

Informational

- Network Compliance
- Resistance Unbalance P2P*
- Resistance Unbalance in Pair*
- TCL*
- ELTCTL*
- ACRN
- PSACRN
- Impendence
- RL Locator TDR
- NEXT Locator TDR
- Shield Locator TDR

* - Parameter can be included as pass/fail using alternate test limits

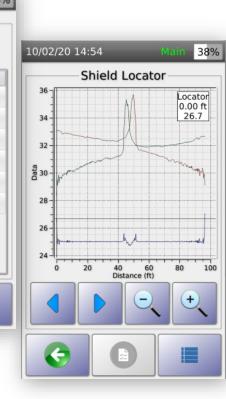
ummary 🥪 Wire	emap Details
Length(ft)	165.7
Delay(ns)	261.0
Resistance(Ω)	9.2
NEXT(dB)	4.7
RL(dB)	3.5
IL(dB)	1.5
PSNEXT(dB)	5.2

Main 46%

10/02/20 14.11

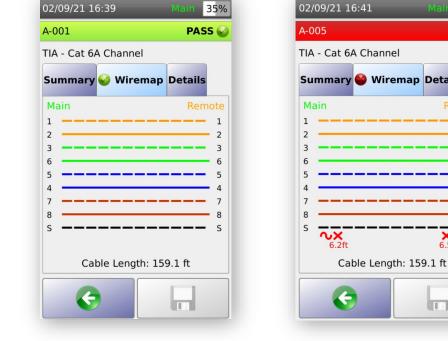
DC	Resistan	ce (Ω)
🖌 Loop 🤇	UnBal. in Pair	UnBal. P2P
Pair	Result	Limit
12-36	0.258	0.519
12-45	1.771	0.519
12-78	0.157	0.519
36-45	2.029	0.519
36-78	0.416	0.519
45-78	1.613	0.519

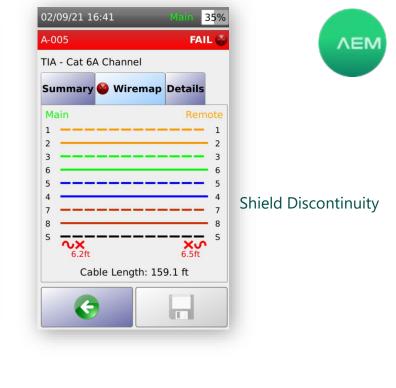
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Wiremap

- Wiremap shows
 - Pair continuity
 - Opens
 - Shorts
 - Crossed pairs
 - Split pairs
 - Shield continuity (if applicable)
- Open unconnected/unterminated wire, cut/broken wire
- Short when two or more copper conductors have physical contact together, sometimes due to wire stripping error or defective insulation on conductors
- Crossed pairs wire pairs are attached to a specified pair of pins at one end, but terminated to a different set of pins at the other end
- Split pairs wires terminated to the connector pins specified for a single pair are split up through two separate pairs in the cable.



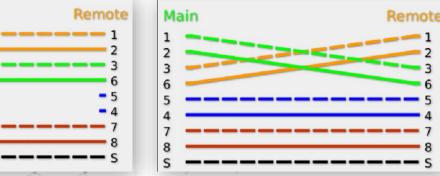




14.7m

14.7m 13.9m





6

Length Measurement

- Most common failure due to incorrect NVP setting.
 - Nominal Velocity of Propagation speed at which electrical signals travel through the cable
 - Expressed as a percentage of the speed of light
 - Use built-in cable library to avoid NVP-based length errors
 - Verify NVP value with cable manufacturer's documentation
- Length test for certification uses the shortest length of the 4 pairs, but all pairs are included in test details
- Standards allow for a 10% buffer in length measurement for pass/fail criteria

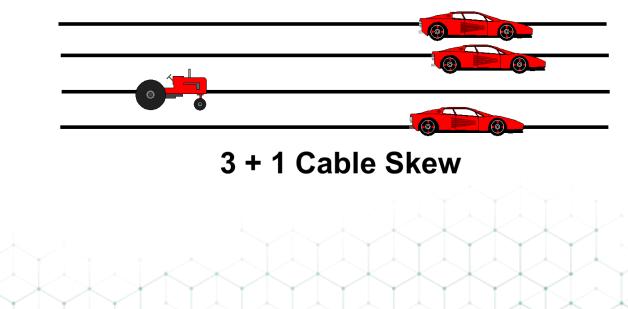
2/09/21 15:	55	Main	40%
	Length (ft))	
Pair	Result	Limi	t
12	159.1	328.	1
36	166.7	328.	1
45	168.6	328.	1
78	159.3	328.	1
	E		





Propagation Delay and Delay Skew

- Propagation Delay the time required for a signal to travel from one end of the transmission path (cable pair) to the other
 - Most common cause of failure length exceeds maximum allowed under the standard
 - Defective cable due to manufacturing deficiencies can also result in failure
- Delay Skew is the difference in propagation delay between any two pairs within the same cable sheath
 - Critical for Gigabit Ethernet and other application which use all 4 pairs
 - Most common cause of failure cable damage or manufacturing problem
 - Substandard connection components or patch cords can also cause failure





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DC Resistance

- DC Loop Resistance
 - Round trip resistance measurement of the pair
- DC Resistance Unbalance In-Pair (not required)
 - Compares the resistance of each of the conductors in the pair
- DC Resistance Unbalance Pair-to-Pair (not required)
 - Compares the resistance of each pair to all other pairs
- As specified in ANSI/TIA-568.2-D and TIA TSB-184A D3.0
 - DC Loop Resistance for Cat3/5e/6/6A shall not exceed 25 Ohms
 - DC Resistance Unbalance <200mOhms or <3% of Unbalance in pair (750mOhms)
 - DC Resistance Unbalance between pairs <200mOhms or <7% of unbalance between pairs

			DC P	lesistar	nce (Ω)			
		🥪 Loo	op 🥪	UnBal. in Pair	Sector UnB P2			
		Pair	r	Result	Lin	nit		
		12		0.077	0.2	53		
		36		0.025	0.2	53		
		45		0.027	0.2	53		
		78		0.005	0.2	53		
46	Mair	54%	,	0	8/05/21	08:50	ľv	lain
Resistan	ce (Ω)		1	E		DC Resi	stance (Ω) —
UnBal. in Pair		Contraction of Contraction			🥹 Loop			nBal P2P
Result	Lim	nit			Pair	Res	ult	Limit
8.134	25.0	00		E	12-36	0.1	57 (0.295
8.760	25.0	00			12-45	0.08	38 ().295
8.484	25.0	00			12-78	0.04	47 (0.295
8.323	25.0	00			36-45			0.295
					36-78	0.10	09 (0.295
					45-78	0.04	10 (0.295
	Resistan UnBal. in Pair Result 8.134 8.760 8.484	UnBal. < UnB In Pair UnB Result Lim 8.134 25.0 8.760 25.0 8.484 25.0	12 36 45 78 46 Main 54% Resistance (Ω) UnBal. in Pair Quadratic sector Result Limit 8.134 25.000 8.760 25.000 8.484 25.000	12 36 45 78 46 Main 54% Resistance (Ω) UnBal. UnBal. P2P Result Limit 8.134 25.000 8.760 25.000 8.484 25.000	12 0.077 36 0.025 45 0.027 78 0.005	12 0.077 0.2 36 0.025 0.2 45 0.027 0.2 78 0.005 0.2 78 0.005 0.2 78 0.005 0.2 (BResistance (Ω) Result Limit 8.134 25.000 8.760 25.000 8.484 25.000	12 0.077 0.253 36 0.025 0.253 45 0.027 0.253 78 0.005 0.253 78 0.005 0.253 78 0.005 0.253 78 0.005 0.253 78 0.005 0.253 78 0.005 0.253 8 0.005 0.253 8.134 25.000 0.012 8.760 25.000 12-45 0.04 8.484 25.000 12-78 0.04	12 0.077 0.253 36 0.025 0.253 45 0.027 0.253 78 0.005 0.253 78 0.005 0.253 78 0.005 0.253 78 0.005 0.253 78 0.005 0.253 78 0.005 0.253 78 0.005 0.253 78 0.005 0.253 78 0.005 0.253 78 0.005 0.253 78 0.005 0.253 78 0.005 0.253 78 0.005 0.253 78 0.005 0.253 78 0.005 0.253 78 0.005 0.253 78 0.005 0.253 78 0.007 0 79 0.007 0 79 0.007 0 70 0.007 0 70 12-45 0.088 0 72-78 0.047

08/05

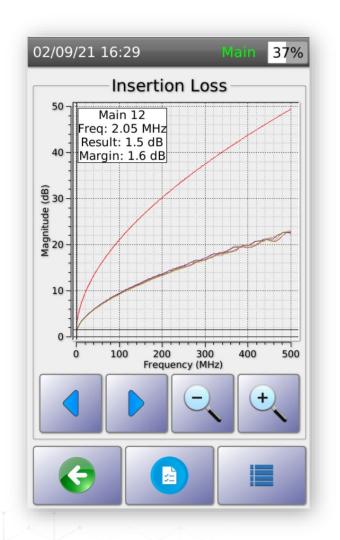
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Pa



Insertion Loss (IL)

- Insertion Loss (aka attenuation) is the loss of power of a transmitted signal as it travels along the cable
- Result measured in decibels (dB)
- Increases with distance (length), temperature and frequency
- Failures
 - Most common cause is excessive length
 - Rarely seen in isolation, typically eliminated once other faults are corrected
 - Wrong wire gauge or category of cable can also be the culprit cable under test may not be suitable for the application
 - Incorrect equipment patch cable (channel test) patch cables are an oftenoverlooked cause of trouble
 - If IL failure is isolated to a single pair, it is likely a termination issue try retermination

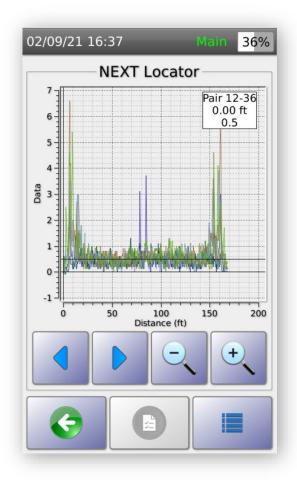




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Near-End Crosstalk (NEXT)

- NEXT is the unwanted signal coupling between pairs
- Measured at the end of the cable nearest transmission
- "Back-in-the-day" example hearing other people conversing over a landline phone, hence the name "crosstalk"
- PSNEXT the combined crosstalk on a tested pair from all other operating pairs, calculated using the results of other crosstalk measurements
- Failures
 - Mixed categories of cabling/termination hardware/patch cables
 - Improper termination
 - Split pairs
 - Incorrect/substandard components
 - Incorrect or defective test cables or test adapters
 - Excessive EMI in the environment
 - Excessive compression by cable ties or supports on cable bundles
 - Cable kinked/damaged during installation
 - Excessive force used when installing cable
 - Use NEXT Locator (TDR) to pinpoint location of crosstalk
 - Use visual inspection to check workmanship



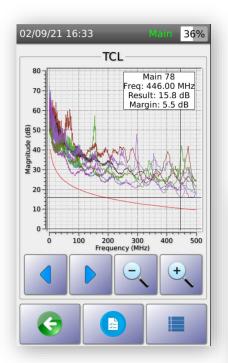
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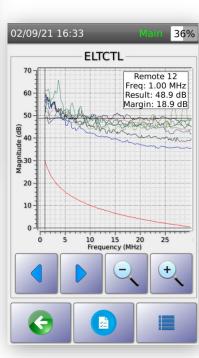
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TCL and ELTCTL (not required)

- TCL Transverse Conversion Loss
- ELTCTL Equal Level Transverse Conversion Transfer Loss
- Not required for field testing, these are done by the manufacturers to ensure conformance
- Signal noise is injected into the cable and the measurements indicate the level of noise immunity to show the cable will perform adequately in noisy environments such as external sources in an industrial environment or alien crosstalk from adjacent cables for 10GBase-T applications
- This is included as an optional test





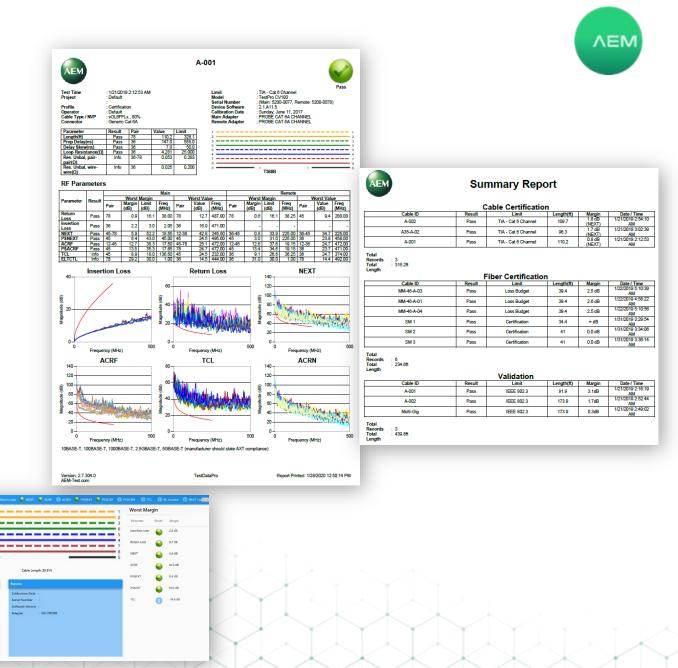
VEN



Test Documentation

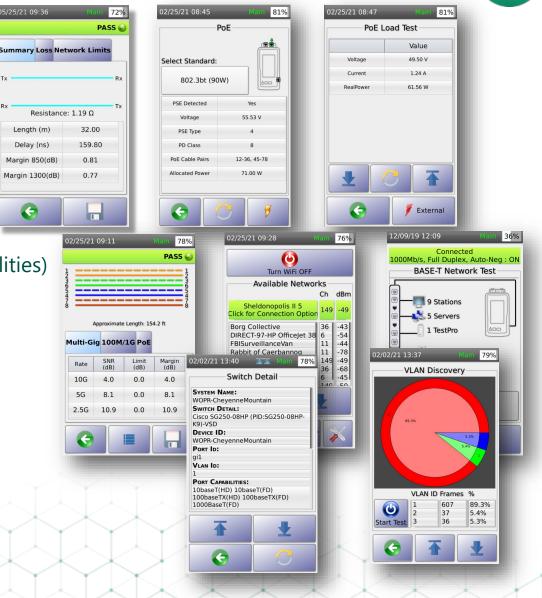
- Provides the end customer a proof of quality
- Protects the installer
- Supports manufacturer's system warranty
- Includes complete test results, details about the test equipment used, test configuration and application compatibility

Home Tools Settings	Hep	1 - 10	1.0	10.10			-					
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State University [29]		↑ Label	Result	Longth	Warst Margin	Worst Margin	Limit	Test Time	Profile	Project	Operator	Ac
State Univ. Expansion [0]	6	E1-1-06	0	95.5 ft	8.60 dB (RL)	5.70 dB (NEXT)	TIA - Cat 6 Channel	4/21/2020 3:48:41 PM	Certification	State Univ. Expansion	т	E
Existing Bldg [23]	7	MDF-1-1-03	0	88.9 ft	1.10 dB (RL)	3.50 dB (NEXT)	TIA - Cat 6A Channel	4/6/2020 4:55:38 PM	Certification	Campus Science Bldg	suc	P
F] Floor 1 (23)	8	MDF-1-1-04	0	09.2 ft	2.40 dB (RL)	3.70 d8 (NEXT)	TIA - Cat 6A Channel	4/6/2020 4:55:56 PM	Certification	Campus Science Bldg	SJC	Z
Room 101 [13]	9	MDP-1-1-05	•	105.0 ft				4/6/2020 5:00:01 PM	Validation	Campus Science Mdg	suc	P
- Rack A [13]	10	MDF-1-1-06	0	124.7 ft				4/6/2020 5:04:22 PM	Validation	Campus Science Bidg	sic	P
Panel 1 (13)	11	MDF-1-1-08	0	108.3 ft				4/6/2020 5:10:32 PM	Validation	Campus Science Bldg	sic	E
Room 102 [10]	12	MDF-1-1-11	0	89.3 ft	5.60 dB (RL)	2.30 dB (NEXT)	TIA - Cat 6A Channel	4/7/2020 10:54:51 AM	Certification	Campus Science Bløg	SJC	D
4 Rack B [10]	13	MDF-1-1-15	•	78.6 ft	2.50 dB (RL)	1.10 dB (NEXT)	TIA - Cat 6A Permanent Link	4/7/2020 11.09:49 AM	Certification	Comput Science Blog	sic	P
Panel 2 (10)	14	MDF-1-1-18	0	78.3 ft	7.30 dB (RL)	1.10 dB (NEXT)	TIA - Cat 8A Permanent Link	4/7/2020 11:14:47 AM	Certification	Campus Science Bldg	sie	P
Expansion Wing [6]	15	MDF-1-1-19	۲	78.9 ft	7.60 dB (RL)	0.30 dia (NEXT)	TIA - Cat 6A Permanent Link	4/7/2020 11:15:11 AM	Certification	Compus Science Blog	sic	D
-	16	MDF-1-1-20	•	105.3 ft	0.64 dB (W1)	0.73 dB (W2)	TIA-568.3-D SingleMode ISP STD Grade	4/7/2020 1:47:33 PM	SM Fiber	Campus Science Bldg	suc	Z
	17	MDF-5-1-25	0	105.0 ft	0.31 dB (WI)		TIA-568.3-D SingleMode ISP STD Grade	4/7/2020 1:50:26 PM	SM Fiber	Cempus Science Blog		
	-	MDE-1-1-22	0	101.1.0	0.05 (8,000)		TA-16A 3-D SouleMode SESTD Grade	4/2/0001520104	SM Eiber	Campus Science Bldo		

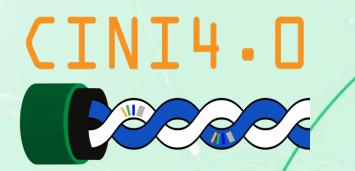


Other Testing Considerations – going beyond physical copper cable tests

- Fiber Optic Loss, including hybrid powered fiber
- PoE Power Over Ethernet validation with true load test
- MultiGigabit SNR testing up to 10GigE data rates
- Network Connectivity Testing wired/wireless
 - Discovery of IP/MAC addresses
 - Connection details (DNS, DHCP, subnet, etc)
 - Switch Detail (switch ID/make and model, port/VLAN/port capabilities)
 - Ping
 - Traceroute
 - SSID discovery and WiFi Signal Strength testing



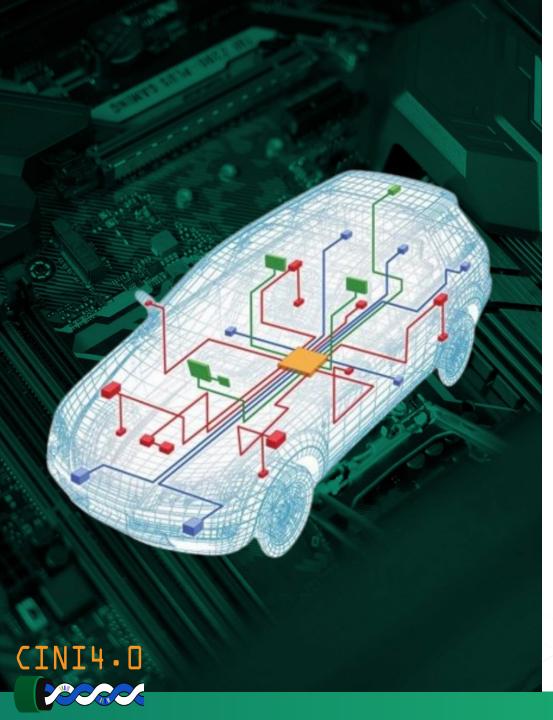
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Single Pair Ethernet





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SPE Adoption – First Automotive

Automotive and Transportation Environments

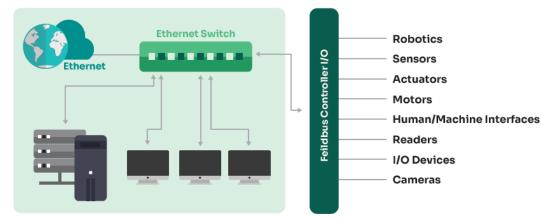
- 802.3bw-2015 100BASE-T1
 - \circ 15 meters 100Mbps
- 802.3bp-2016 1000BASE-T1
 - 15 meters Cars, 1Gbps
 - o 40 meters Aircraft, Railway, Bus, Heavy Trucks, 1Gbps

Power delivery over one pair

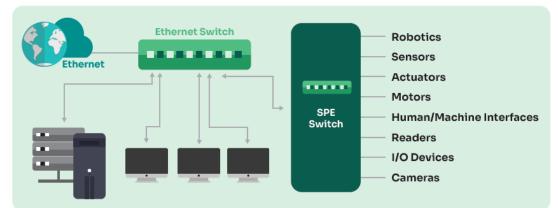
- 802.3bu-2016 Power over Data Lines (PoDL)
 - Pronounced "poodle"
 - Also referred to as SPoE
 - Up to 52W of power

SPE Adoption Then Industrial

Fieldbus Topology



Single Pair Ethernet Topology



The industrial Internet of Things (IIoT)

is a major use case.

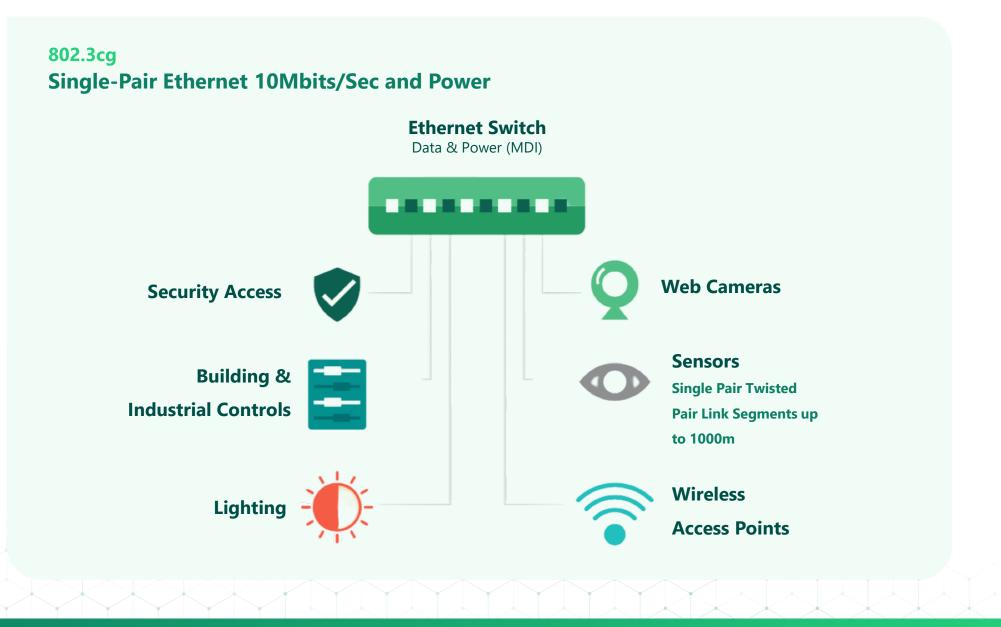
SPE can replace many instances of Fieldbus or other non-Ethernet automation networks.

SPE is perfect for sensors and devices that need limited power and bandwidth but do require efficient, fast, reliable transmission.

On 18 AWG wire, 7.7W of power can be delivered over 1000m

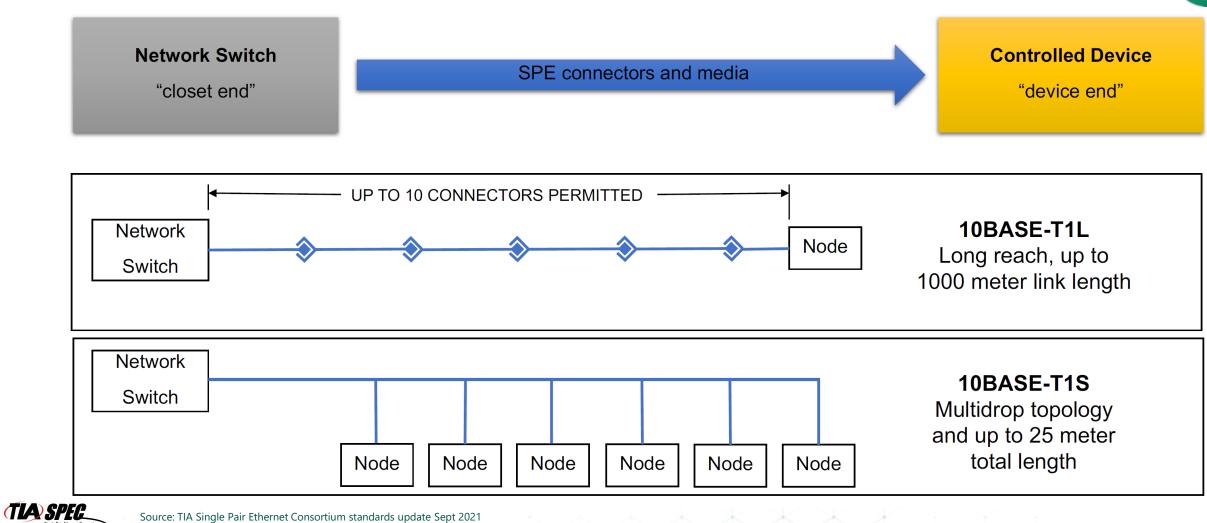
ЛЕМ

Now | SPE is coming to a building near you



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Single Pair Ethernet General Topologies



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Distance	AWG	No. of Connectors	Max Power
1000m / 3280ft	18	10	7.7W
451m / 1480ft	18	10	20W
187m / 614 ft	18	2	52W
58m / 190 ft	23	2	52W



SPE Connector variants



	IEC 63171-1	IEC 63171-2	IEC 63171-3	IEC 63171-4	IEC 63171-5	IEC 63171-6	IEC 63171-7
Туре	LC - Style	Rectangle	TERA 1P	Square	M8/M12	Rectangle/M 8/Push Pull	M12/Power
# Pairs	1	1	1/4	1	1/4	1	1
Company	CommScope	RdM, PxC, WM	Siemon	BKS	PxC, WM, RdM	Harting	PxC, TE

Source : ISO/IEC 63171



Single Pair Ethernet



Single Pair Ethernet Field Testing

 Only when we can test an installation, can we be assured that it is all done correctly ΛEN

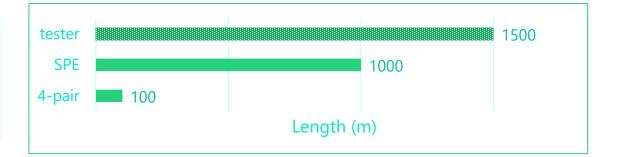
- ✓ Field testing is an important piece in SPE rollout
- In next few slides, we review the current status of field testing SPE links



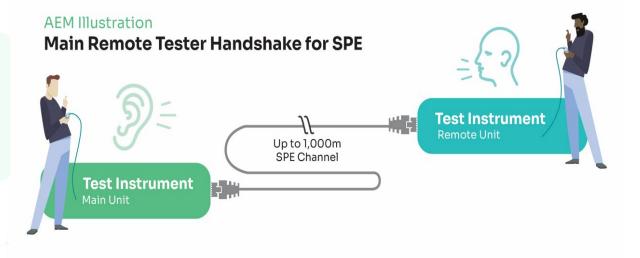
Single Pair Ethernet vs 4-Pair Cabling Test Requirements



SPE cabling standard specifies 1,000m; but test instruments are expected to work with even longer link lengths (~1,500m)



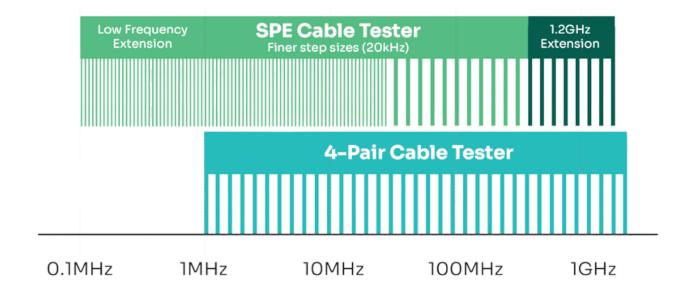
Test equipment main and remote units must perform end-to-end synchronization and communication over long single-pair DUTs





Single Pair Ethernet vs 4-Pair Cabling Test Requirements





Lower range of frequencies extended to 0.1MHz instead of 1MHz

Finer frequency resolution **to locate faults over longer lengths**

20kHz (TBD) minimum step size compared to
 150kHz for 4-pair cable tester



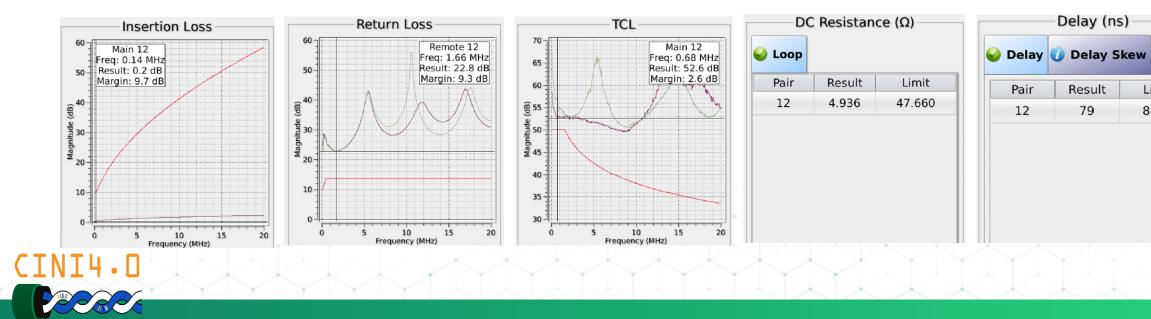
Single Pair Ethernet Standard parameters from Field Testing perspective



Limit

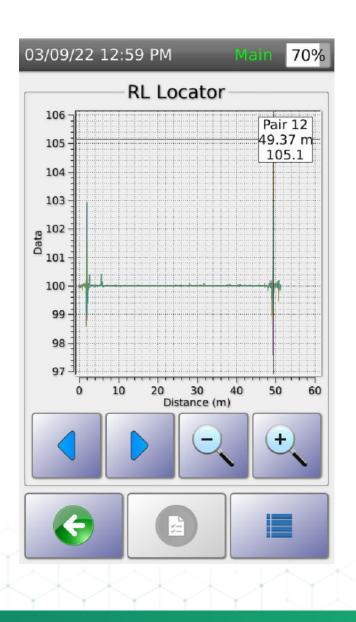
8834

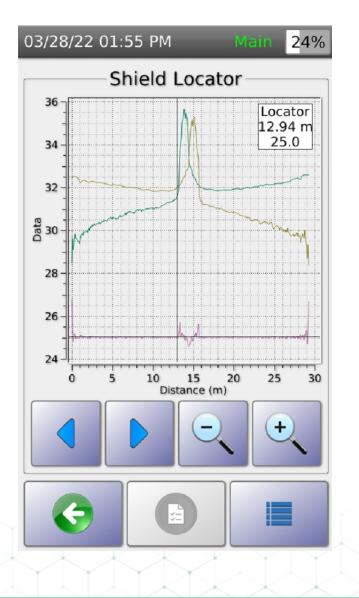
	Parameter	IEEE 802.3cg	ANSI/TIA-568.5	A-002	PASS 🥥
1	Insertion Loss	\checkmark	\checkmark	10BASE-T1L UTP E1 10 Summary & Wirem	
2	Return Loss	\checkmark	\checkmark	Length(m)	16.1
3	TCL (UnShielded)	\checkmark	\checkmark	Delay(ns) DC Resistance(Ω)	79.0 4.9
4	DC Loop Resistance	\checkmark	\checkmark	RL(dB)	9.3
5	Delay	8834ns (AWG 14 @ 1589m)	5559ns (AWG 18 @ 1000m)	TCL(dB) IL(dB)	2.6 9.7



Troubleshooting Tools – locate the point of failure







Connectivity & DC test for SPE





Shield Continuity Measurement

End-to-end shield presence test



Resistance Measurement

DC loop resistance

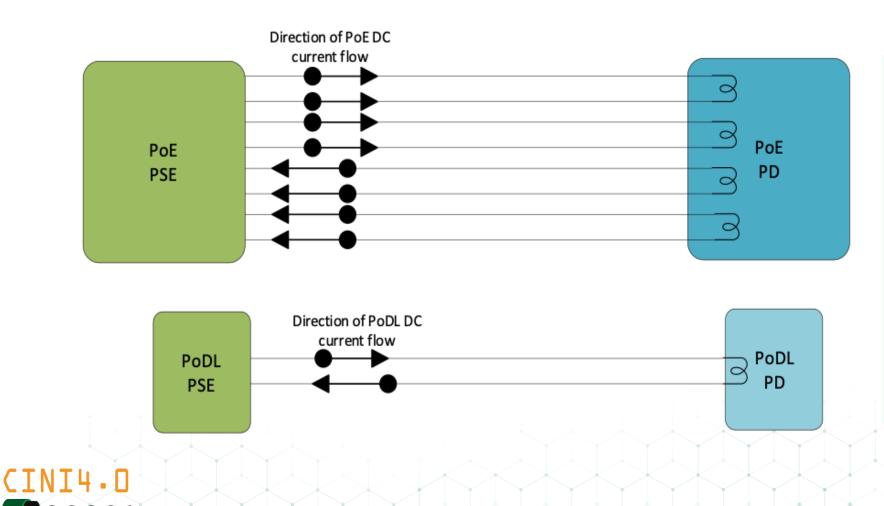


Resistance Unbalance Measurement

Only shielded SPE cables can be tested for resistance unbalance between two signal wires



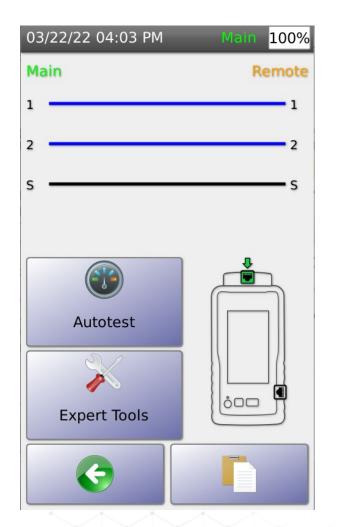
DC Powering SPE vs 4-Pair Cabling



Resistance unbalance is not as big a concern for SPE because **PoDL** current flows in opposite directions in transformer magnetics (unlike PoE) ΛEM

TestPro Single Pair Ethernet Test Example





CINI4.D

PM Ma	in 100%
ct: Default	
-	
TIA-568.5 SP CH STP	1-1000
Simple Labe	1
Default	
Edit	
Pro Man	
	ect: Default Single Pair E Single Pair E TIA-568.5 SP CH STP SPE, Generic Shielded, NV SPE, Generic Shielded, Sh Simple Labe Default

Length(m) 105.6
Delay(ns) 518.0
DC Resistance(Ω) 14.4
RL(dB) 6.2
IL(dB) 9.0

Single Pair Ethernet Test Equipment



SPE testers may be available in one of two varieties:

• Existing cable certifiers with new adapters for SPE

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New testers specifically for SPE



Single Pair Ethernet Field Test Equipment

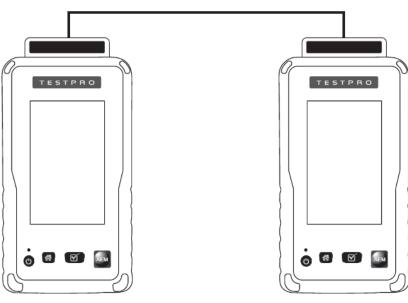
Advantage of existing field testers support for **SPE testing vs new testers**

Significantly lower cost of ownership with adapter based enabling of new test needs

A single test platform covering needs for **4-pair and SPE** cable testing

Easily scale to requirements ranging from **20MHz to 1.2GHz** max frequency





Main

Remote

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SPE Summary

Single Pair Ethernet for a common intelligent Building Network

- ✓ Extends Ethernet network to new systems and devices
- ✓ Offers the potential to quickly deploy and power building IoT devices

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SPE cables will have the capability to safely deliver power to all kinds of new devices

Single Pair Ethernet cabling will be tested in familiar ways using existing testers with new adapters



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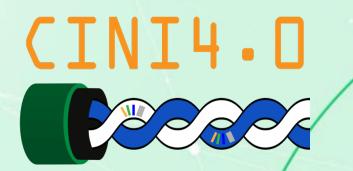


Thank You!

Please visit the AEM/Heynen stand for live demonstration.

Interested in a demo? Heynen is local partner for AEM test within the Benelux region. Account manager Heynen nv: Joris Schreurs, joris.schreurs@heynen.be





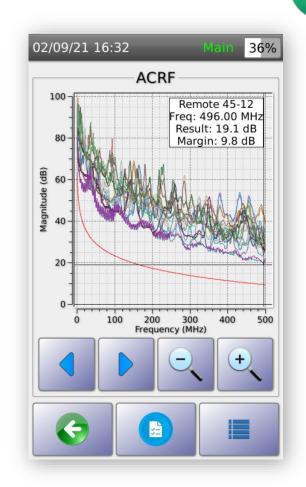




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ACRF and PSACRF

- Attenuation-to-Crosstalk Ratio
 - NEXT minus IL = ACR
- ACRF is Attenuation-to-Crosstalk Ratio Far End
 - Far End ACR minus IL = ACRF (formerly known as ELFEXT)
- PSACRF is Power Sum Attenuation-to-Crosstalk Ratio Far End
 - Calculation of the combined ACRF on a tested pair from the three remaining pairs
- Bandwidth is determined by using ACR measurements
- Impacted by same factors as NEXT, including incorrect or substandard cable/components, improper termination, mismatched patch cords
- TestPro's Autotest also includes the Near-End tests of ACRN and PSACRN for informational purposes





What's driving the demand?

- Bandwidth consumption by personal IoT devices
- Expected growth to 75 billion by 2025
- Low bandwidth devices can be offloaded to SPE
 - Access controls
 - Lighting
 - Cameras
 - Sensors
 - Industrial controls



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Single Pair Ethernet Standards

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IEEE 802.3cg. – 10Mb/s (2019)

- 10BASE-T1S Link segment (point-to-point), 4 connections, 15m reach, PoDL power
- 10BASE-T1L Link segment (point-to-point), 10 connections, 1000m reach, PoDL power
- 10BASE-T1S Mixing segment (multidrop), 8 nodes, 25m reach

IEEE 802.3da. – 10Mb/s (TBD) Multidrop Enhancements

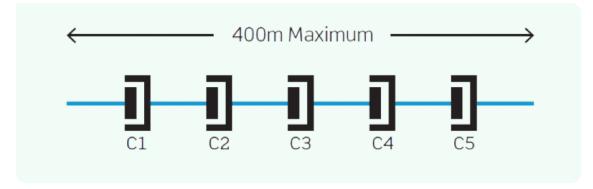
IEEE 802.3bu. – 10Mb/s (2016) Power Over Data Line (PoDL)

• Power delivery over single twisted-pair segment

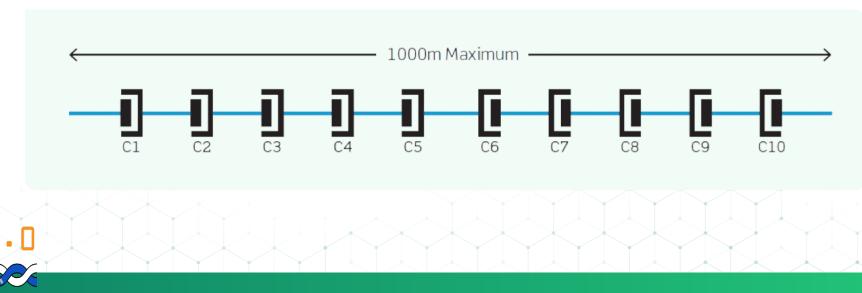


Single Pair Ethernet Topologies – Wire Size Matters

SP1-400 Channel (23 AWG)



SP1-100 Channel (18 AWG)



AEM

Single Pair Power Over Ethernet – PoDL vs SPoE

- IEEE 802.3 originally standardized powering over a single pair of conductors at 100Mb/s and 1000Mb/s in IEEE 802.3bu, known as Power over Data Lines (PoDL).
- IEEE 802.3cg extended the specification to support 10Mb/s for OT environments.
- In practice there are two variants of single-pair powering, SPoE and PoDL.
 - SPoE is used to describe the classification-based implementation utilized in OT networks
 - PoDL is used in engineered networks, e.g., in-car networks





Source: Ethernet Alliance Tech Brief SPE/SPoE July 2021



SPE Adapters Variants Roadmap



